Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/964,537	SHIN, YEONG JONG		
Examiner	Art Unit	-	
Soon D. Hyun	2616		

T.	SEARCHED				
Class	Subclass	Date	Examiner		
	-, ,				
	<u>.</u>				

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	 				
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
370/331,335,336,342,347; 455/436- 444,448; text search only-see search history printout	7/18/2006	нү		
				